

LIST OF PRIOR ART CITED BY  
APPLICANT  
(PTO-1449)

ATTY. DOCKET NO. **KC-0040** APPLN. SERIAL NO. **09/592,563**

**APPLICANT(S)**

FILING DATE | GROUP  
June 12, 2000 | 2683

## U.S. PATENT DOCUMENTS

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U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

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## FOREIGN PATENT DOCUMENTS

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
lu	WO 97/41654	11/06/1997	Europe	—	—	✓	
ce	WO 99/66746	12/23/1999	Europe	—	—	✓	

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**

EXAMINER C. Lee Nguyen /Lee Nguyen/ (05/08/2009) DATE CONSIDERED 5/08/2009

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